

L' ESPERIMENTO DI YOUNG REALIZZATO CON ELETTRONI

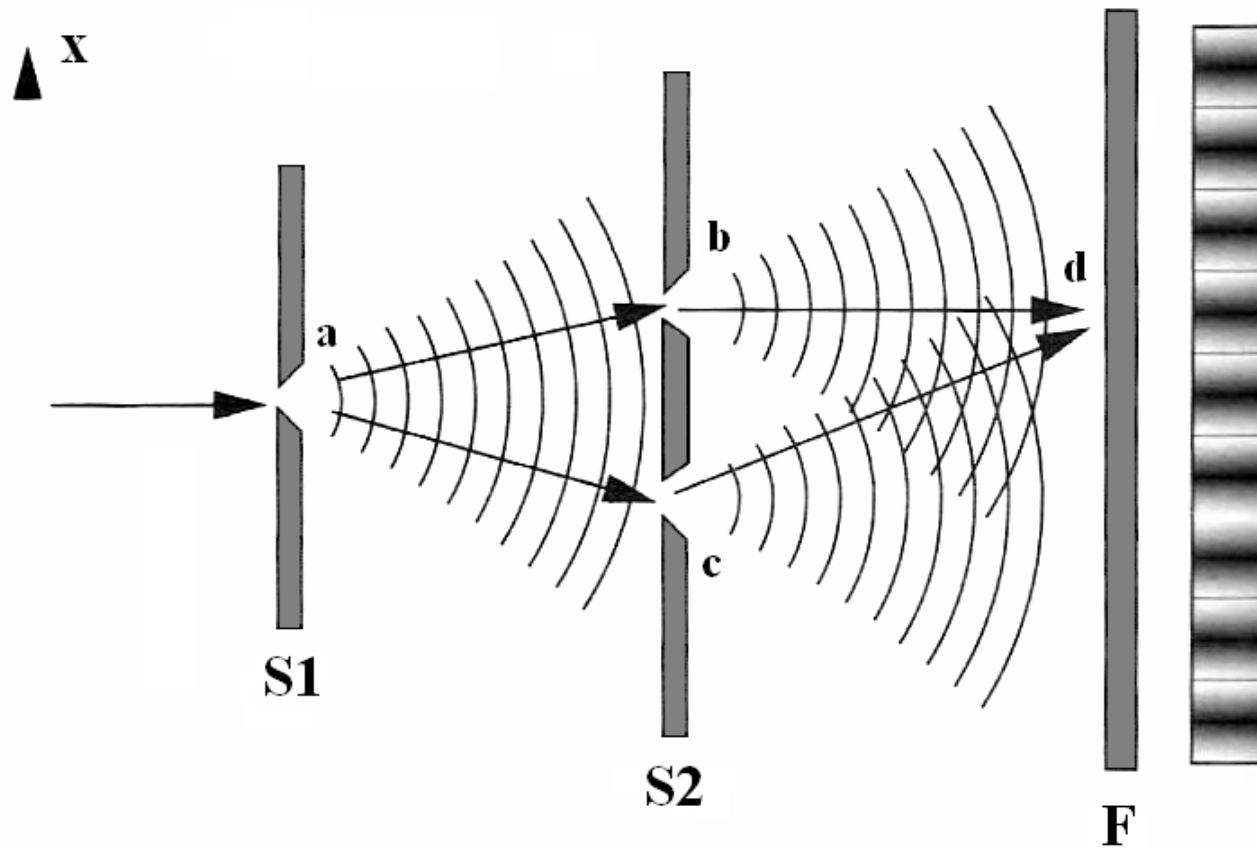
Giorgio Matteucci

Università - Bologna

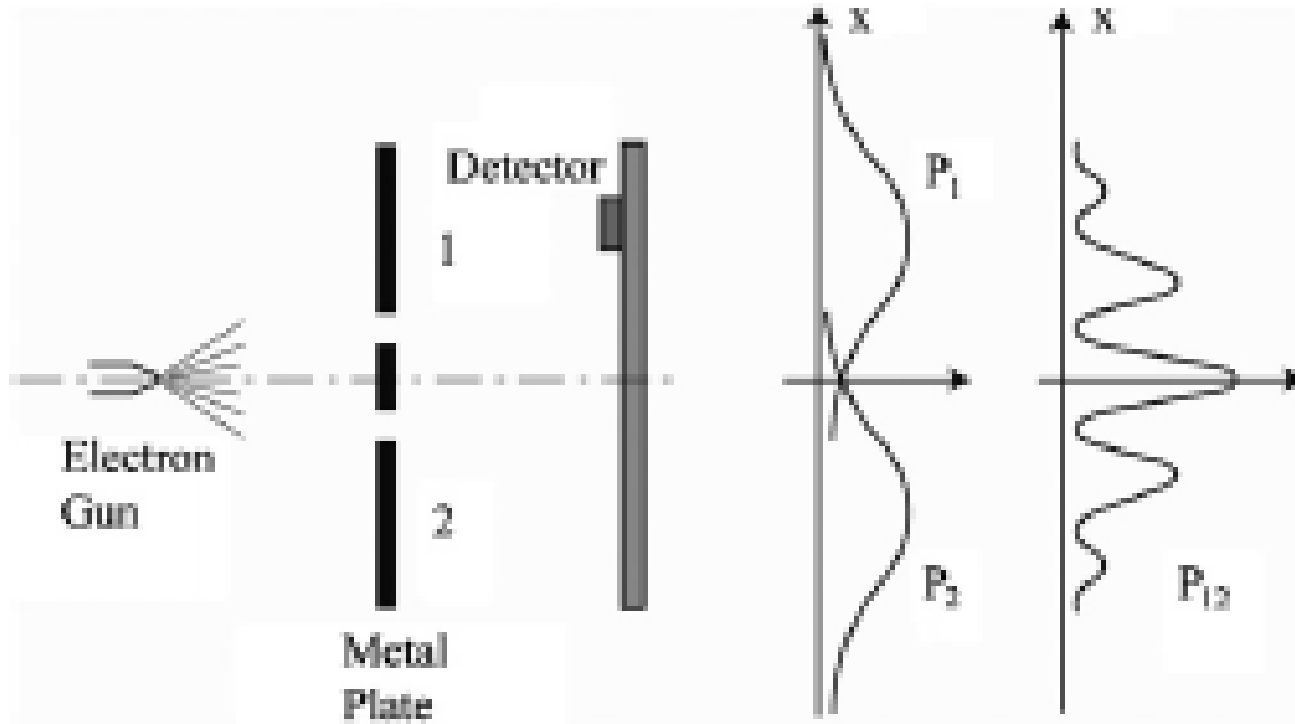
- Esperienza di Young con singoli elettroni
 - Doppia fenditura; un elettrone alla volta

- Strumentazione
 - Microscopio elettronico
 - La doppia fenditura
 - Il sensore APSEL4D

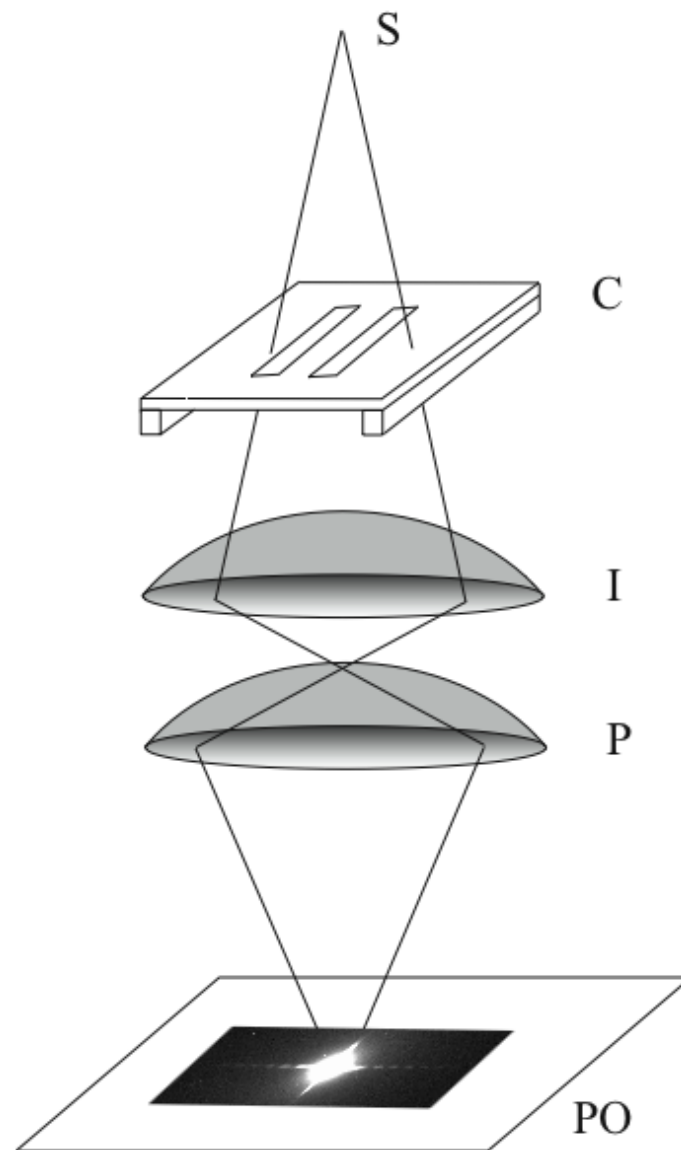
ESPERIMENTO DOPPIA FENDITURA - LUCE

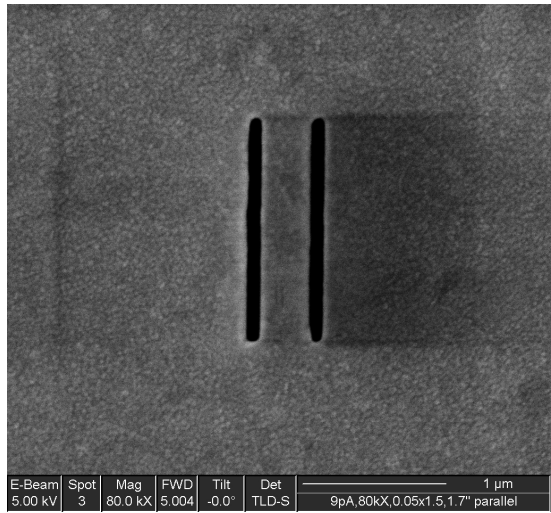


ESPERIMENTO DOPPIA FENDITURA - ELETTRONI



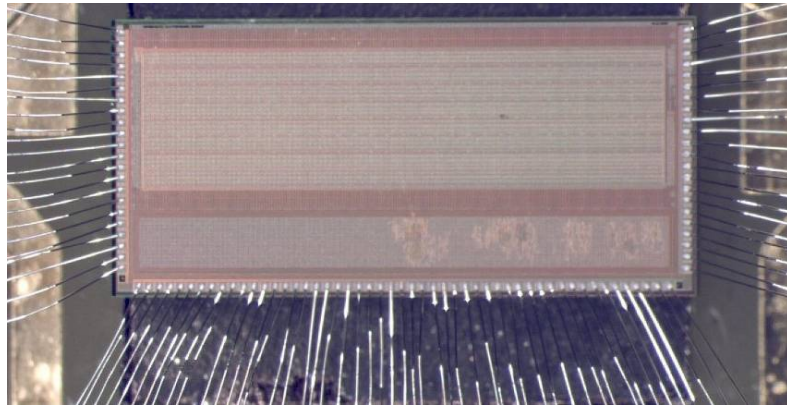
SCHEMA ELETTRO-OTTICO





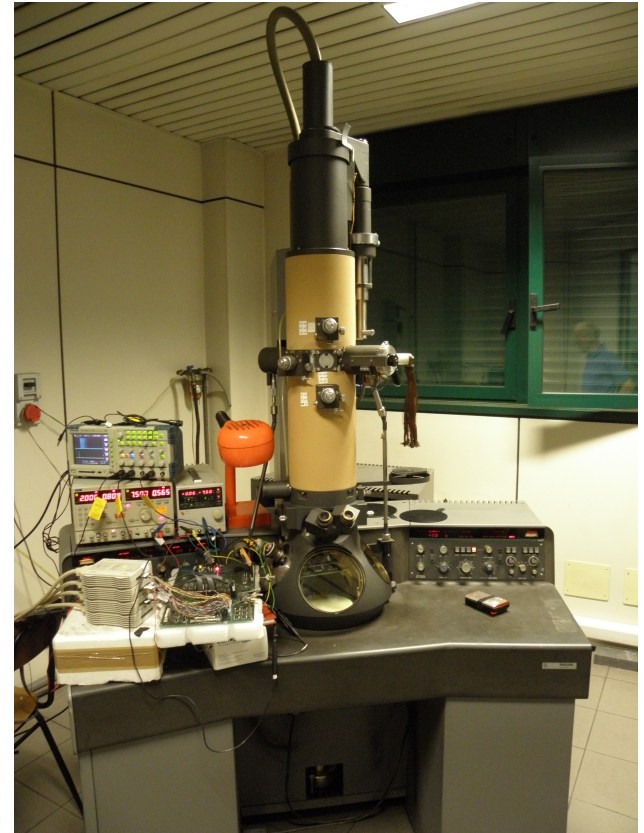
E-Beam	Spot	Mag	FWD	Tilt	Det		1 μ m
5.00 kV	3	80.0 kX	5.004	-0.0°	TLD-S	9pA, 80kX, 0.05x1.5, 1.7" parallel	

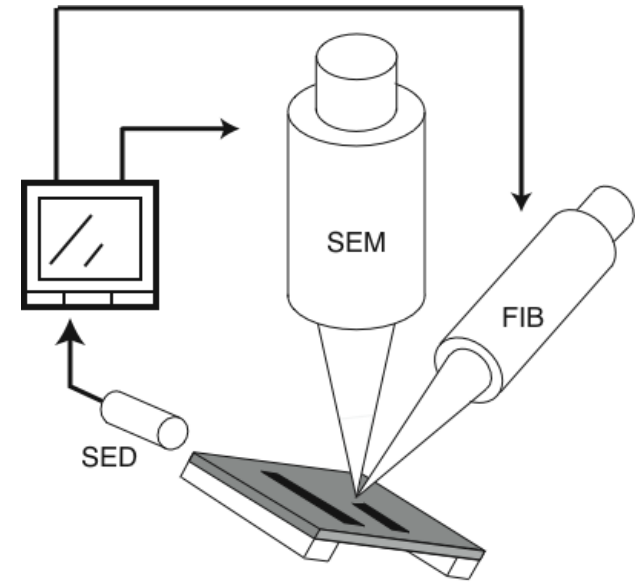
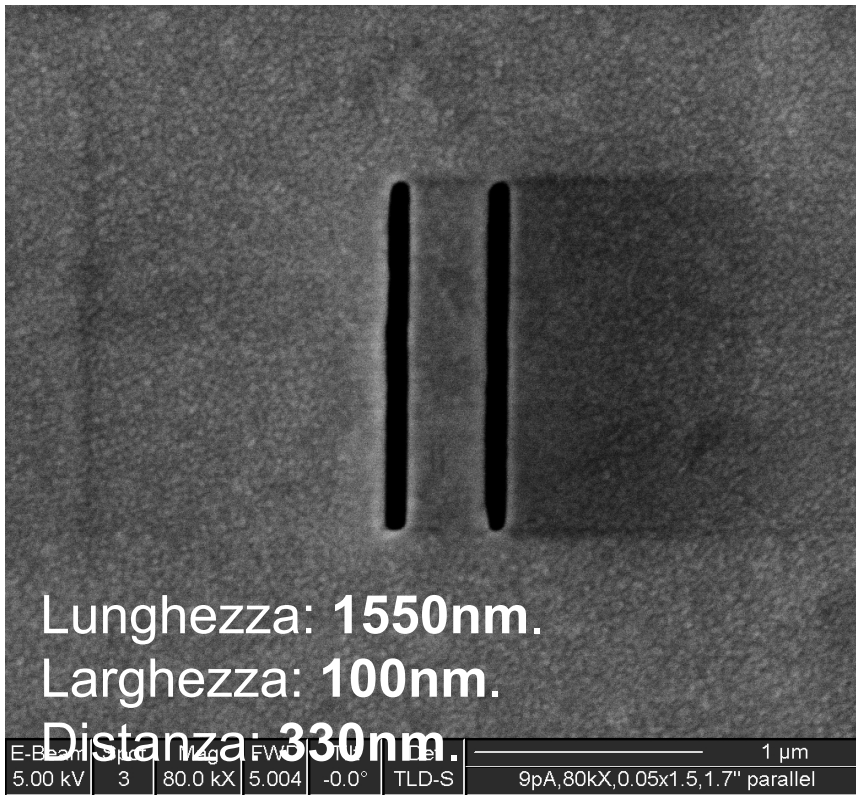
FENDITURE



RIVELATORE

TEM





Realizzate con processo FIB
(fascio di ioni concentrato proveniente da una sorgente di Ga⁺ liquido).
Membrane di carbonio con deposito d'oro (spessore 50-100nm).

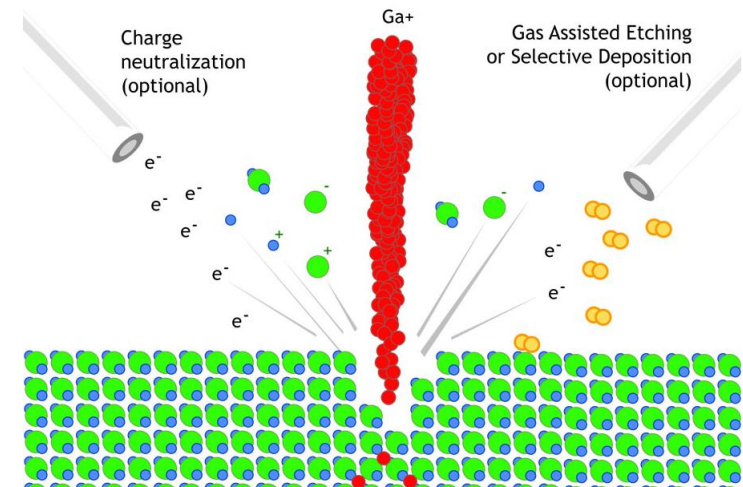
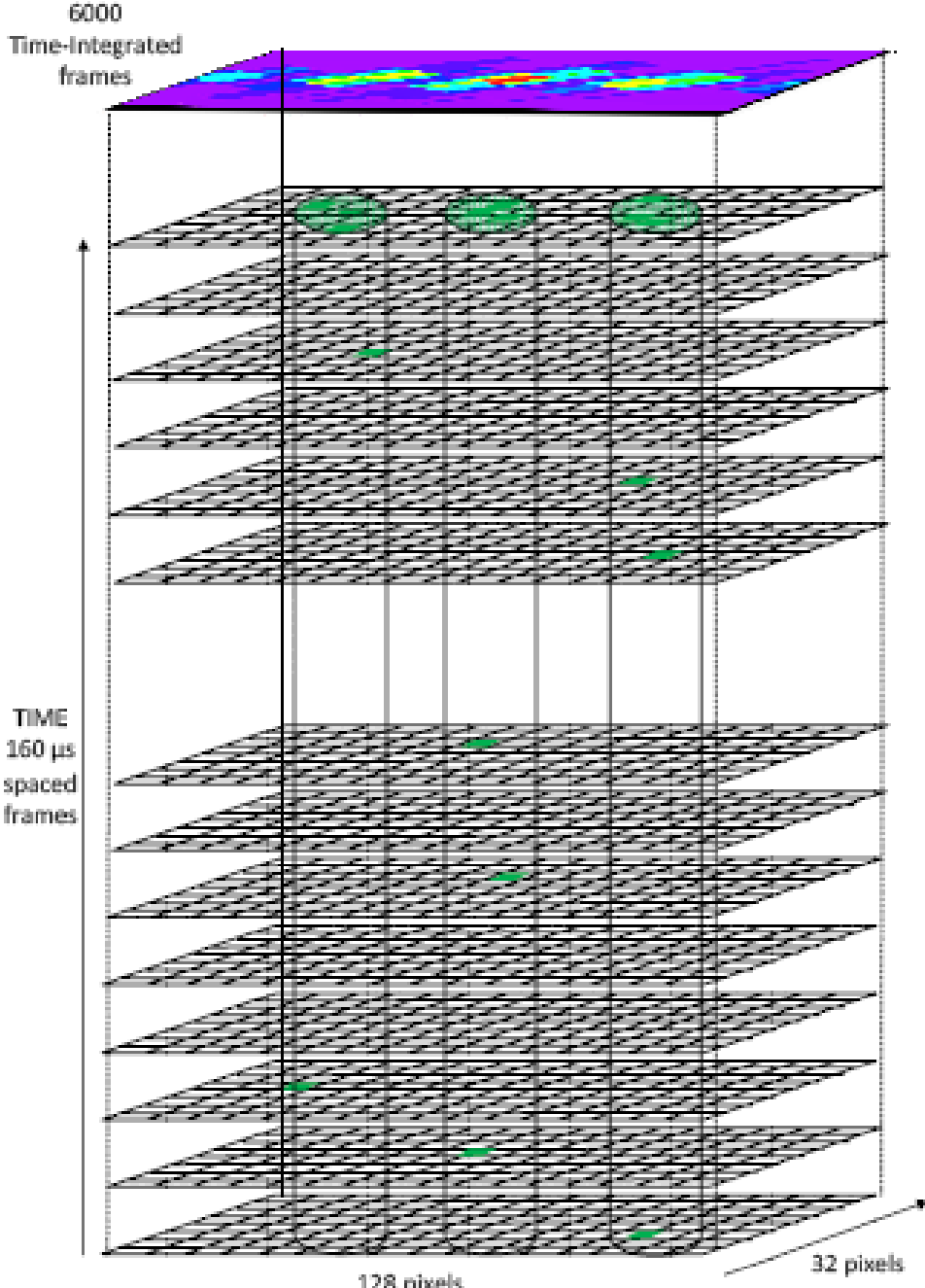
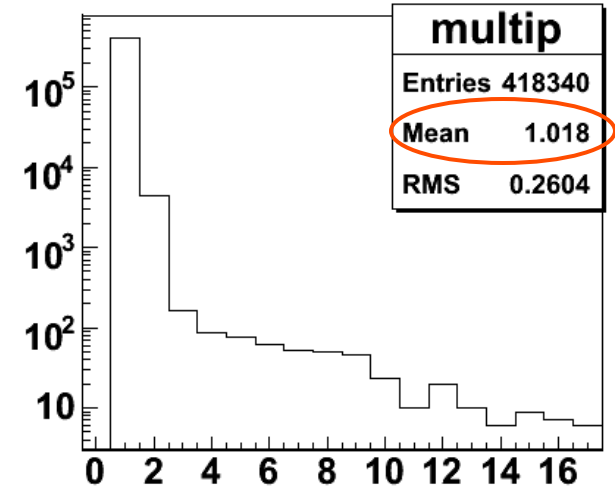
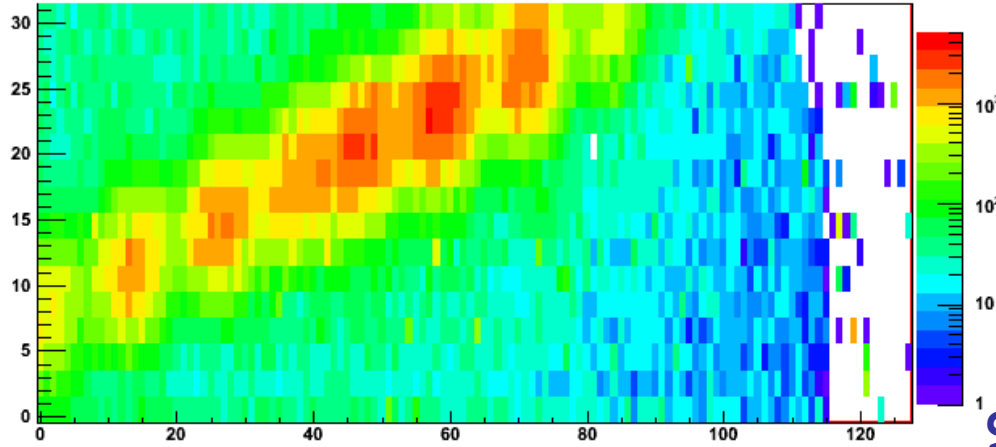


FIGURA INTERFERENZA SOVRAPPOSIZIONE MULTI FRAMES

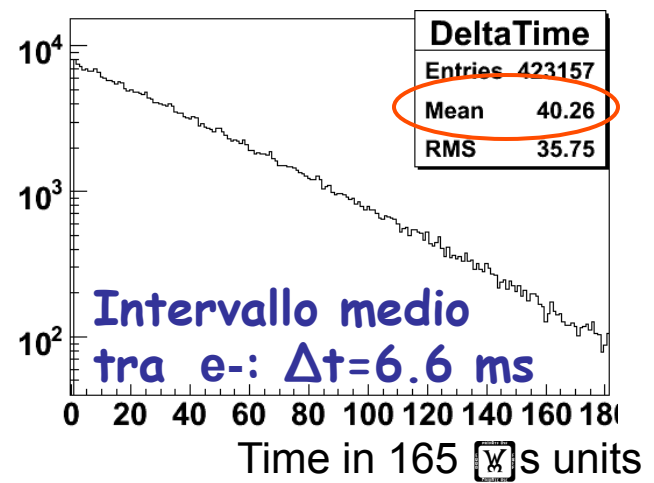
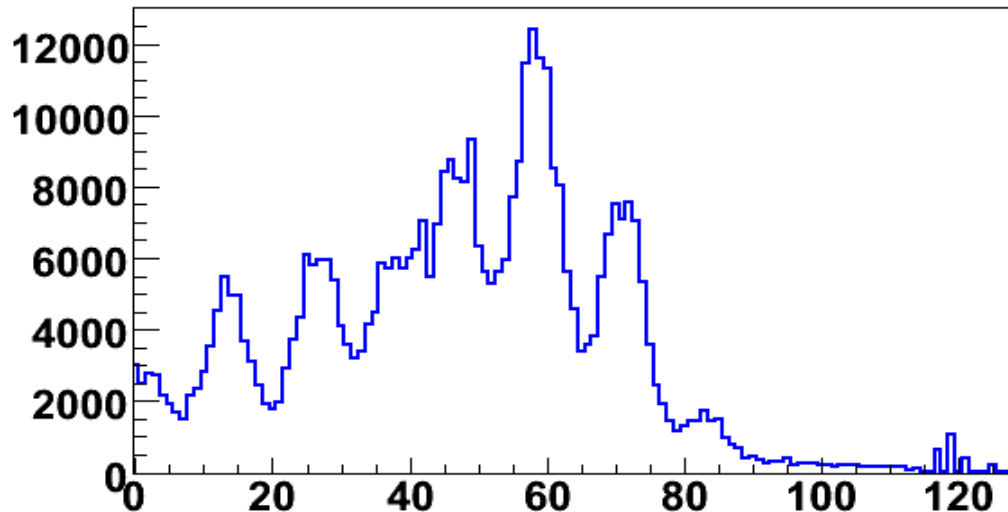


Interferenza di singolo elettrone

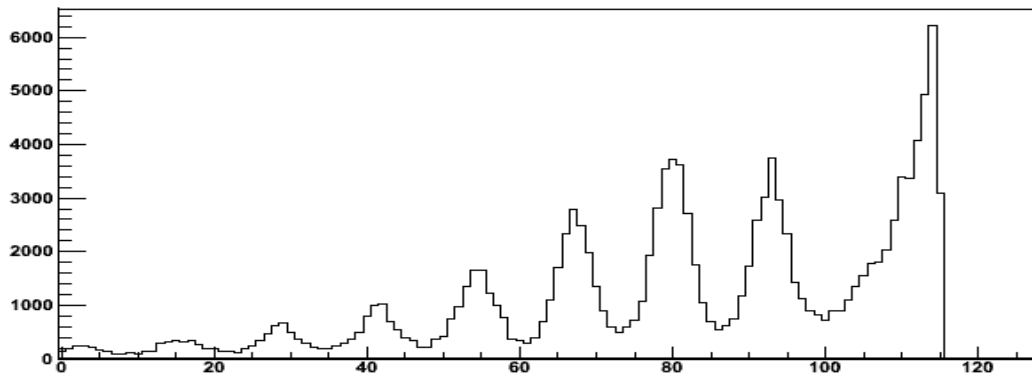
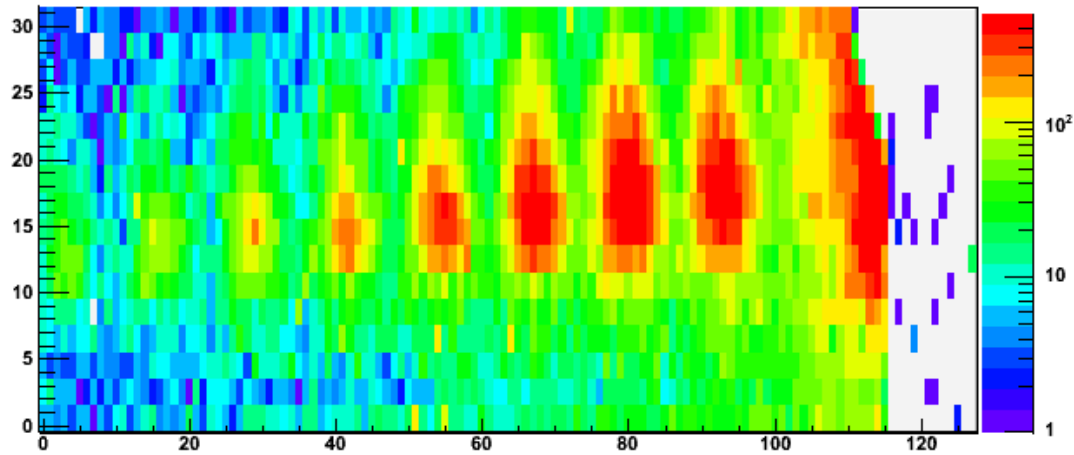
430k elettroni osservati in circa 1h di misura



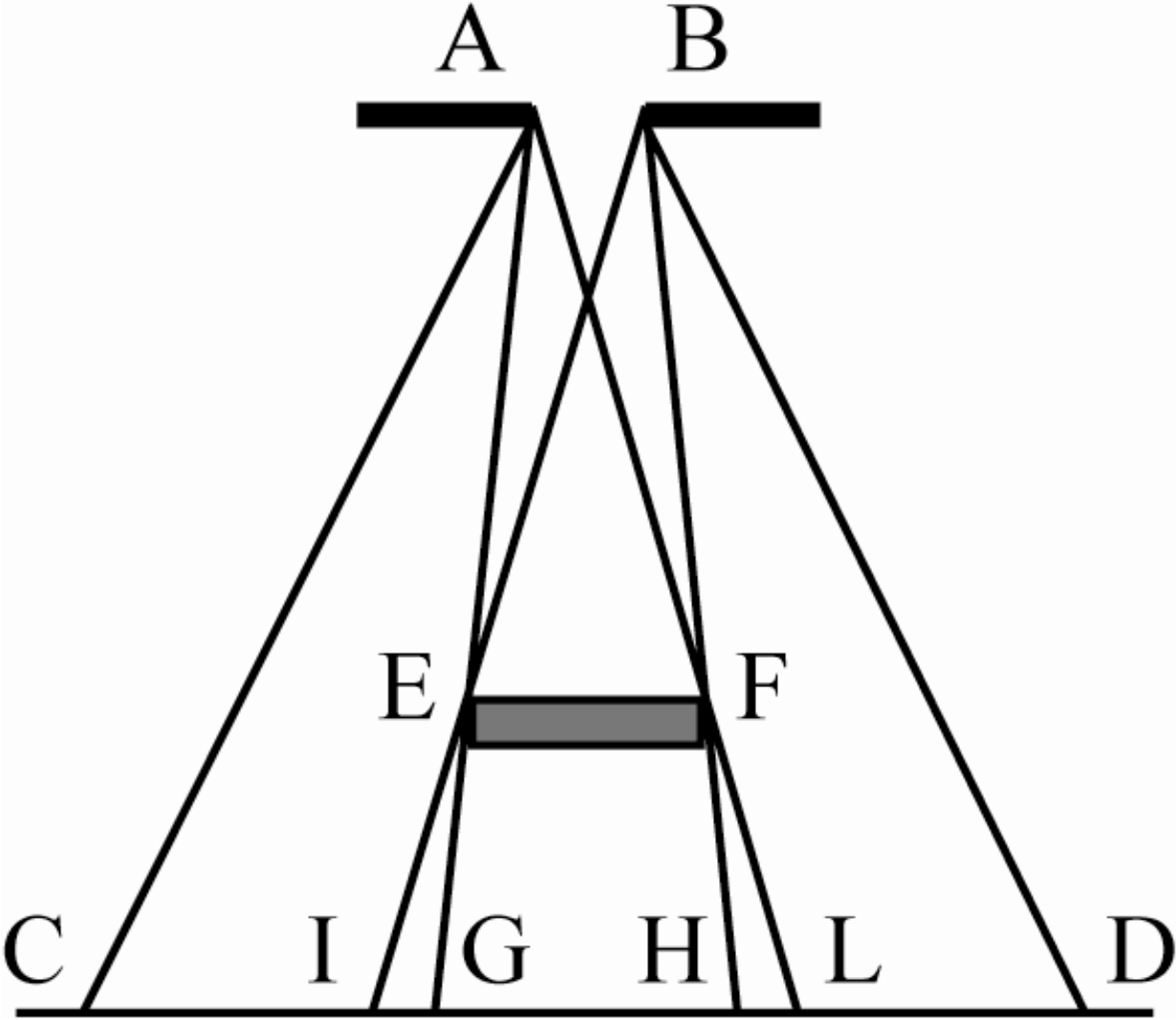
98.8% immagini di singolo e^-



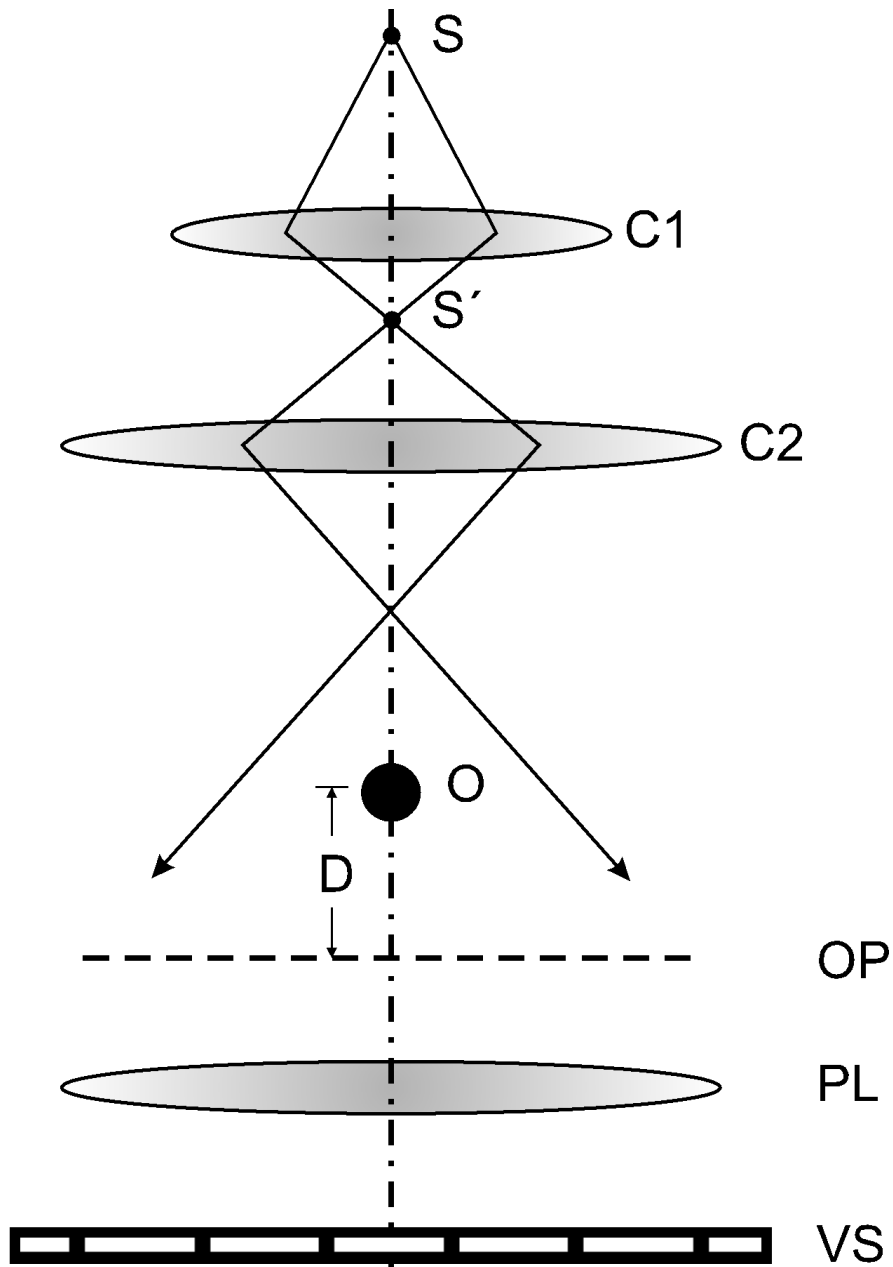
INTERFERENZA DA RETICOLO DI CARBONIO - ELETTRONI SINGOLI



ESPERIMENTO DI GRIMALDI

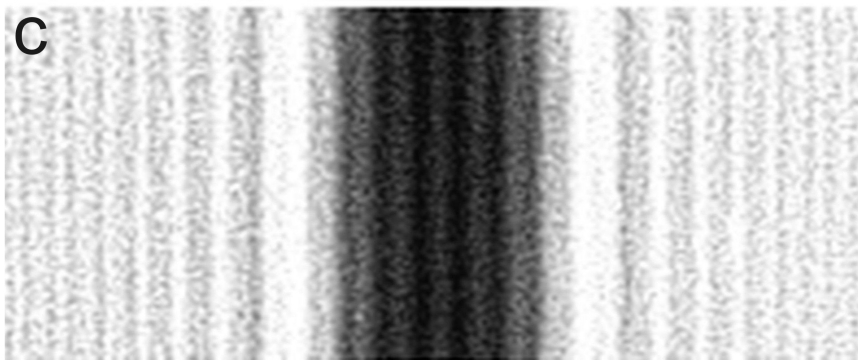
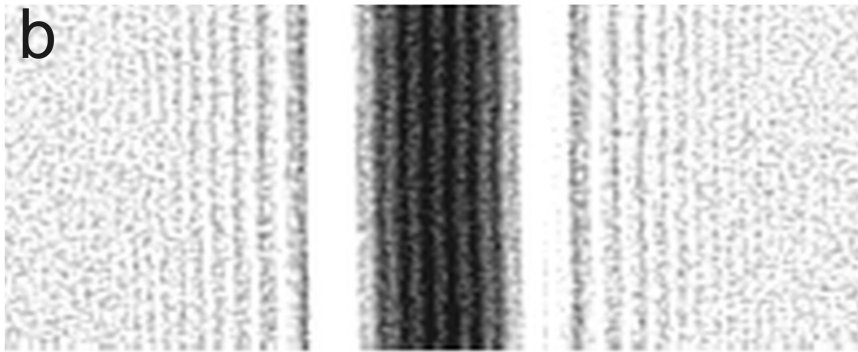
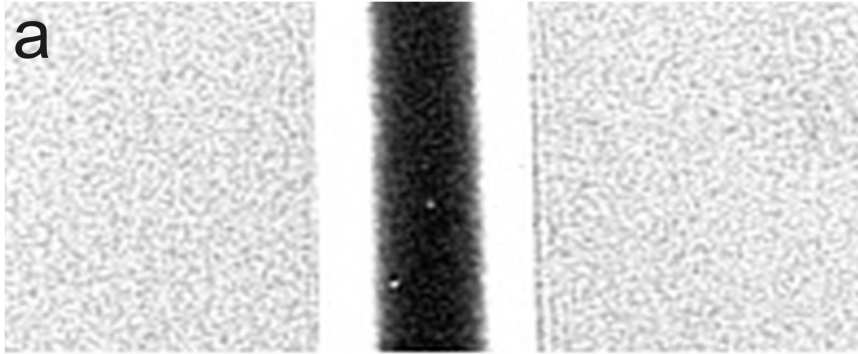


ESPERIMENTO DI GRIMALDI CON ELETTRONI

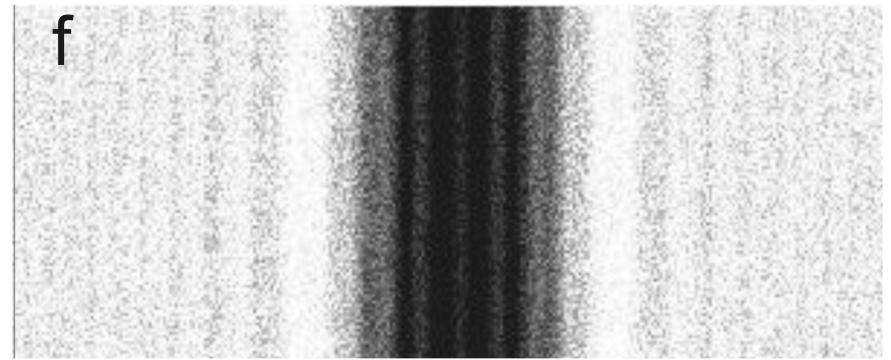
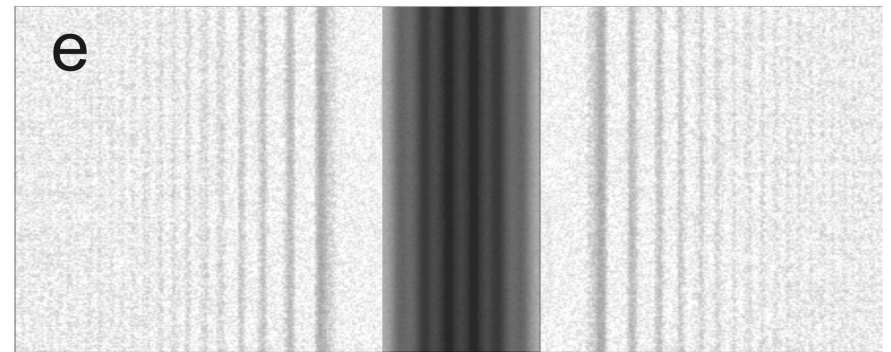
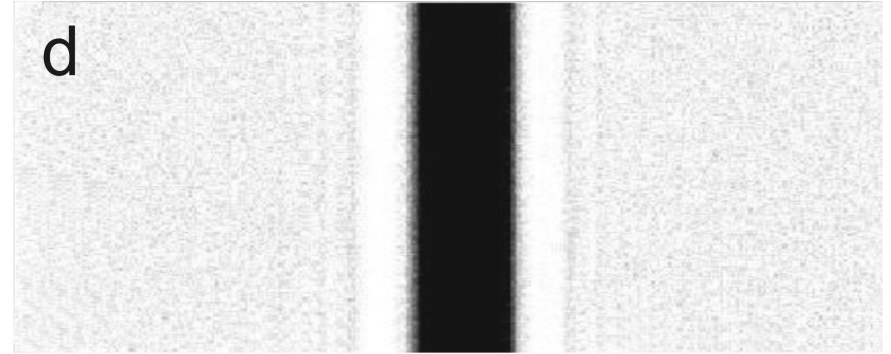


ESPERIMENTO DI GRIMALDI CON ELETTRONI – INTERFERENZA E DIFFRAZIONE DA UN FILO

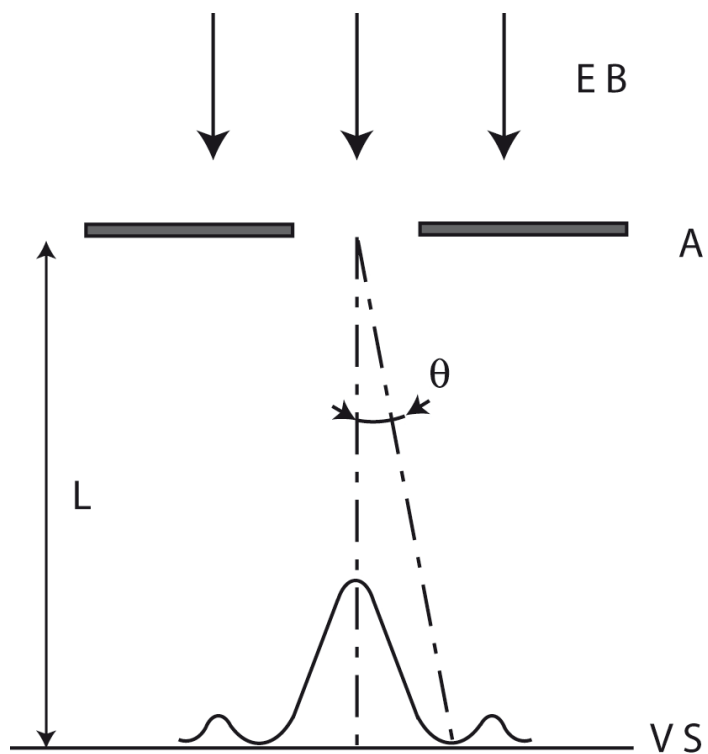
RISULTATI SPERIMENTALI



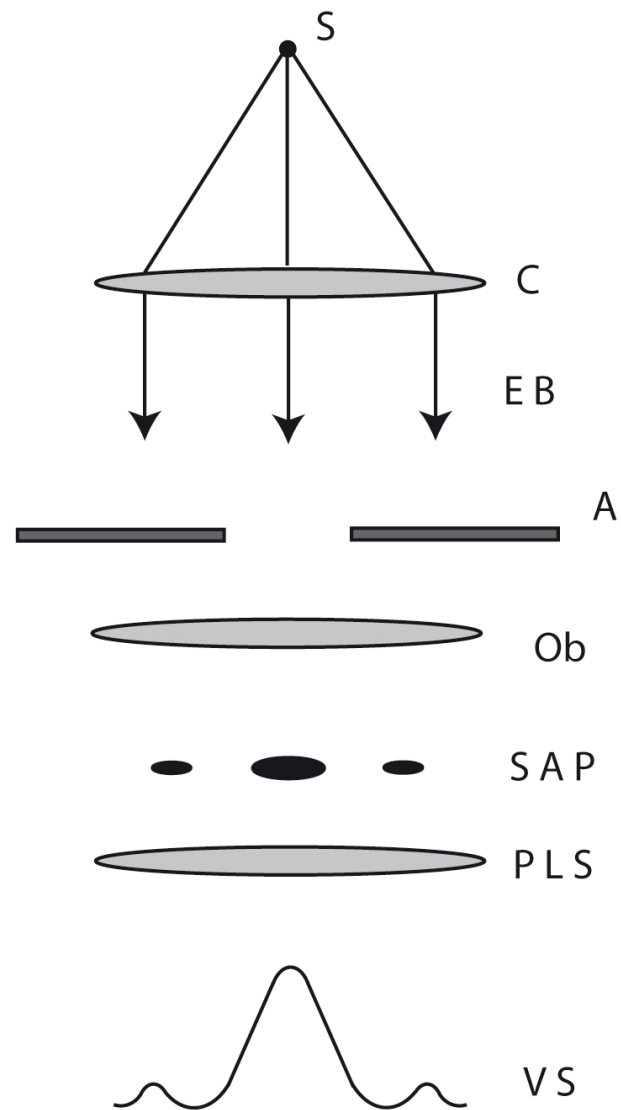
SIMULAZIONI



DIFFRAZIONE CON ELETTRONI

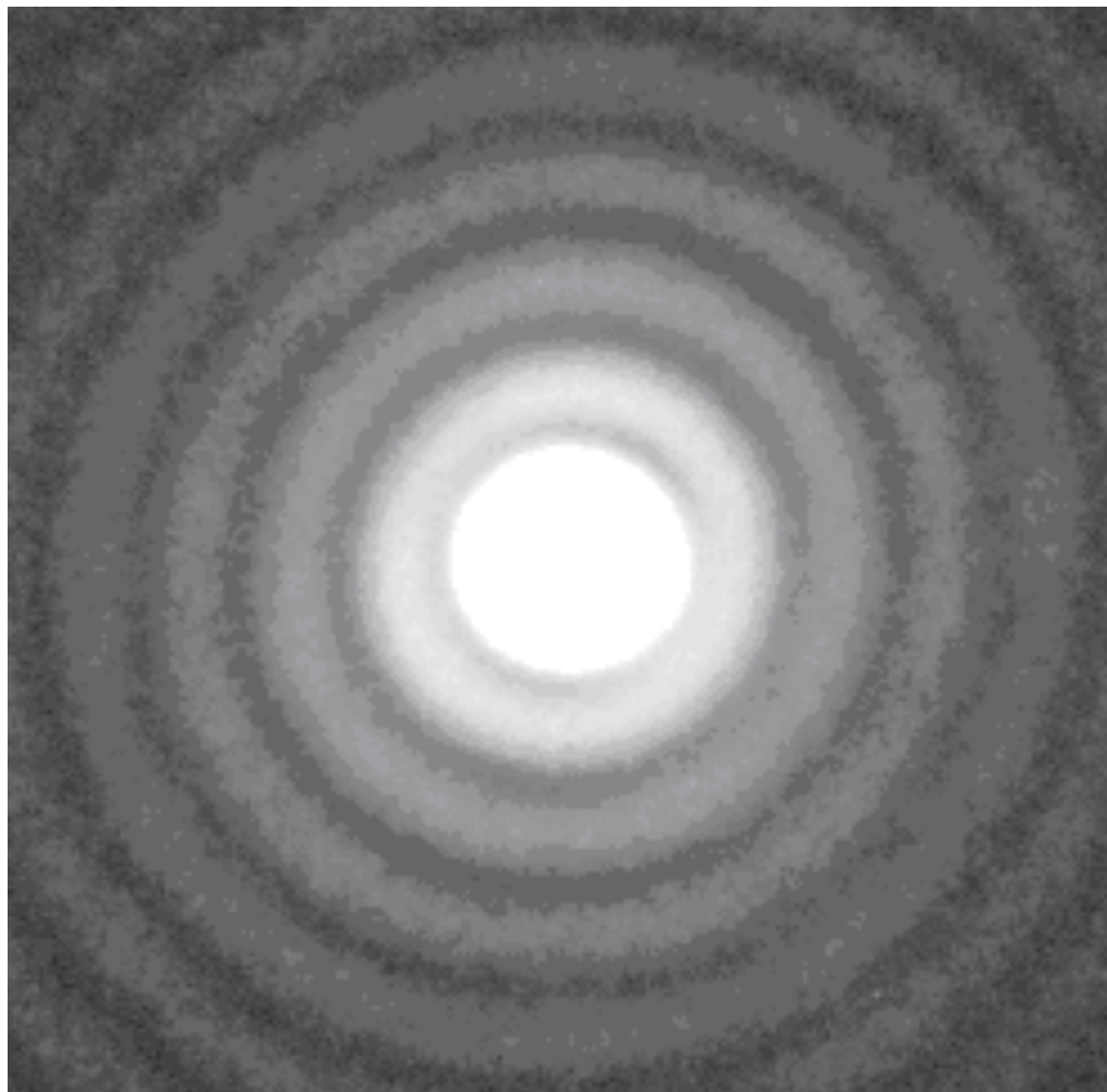


(a)

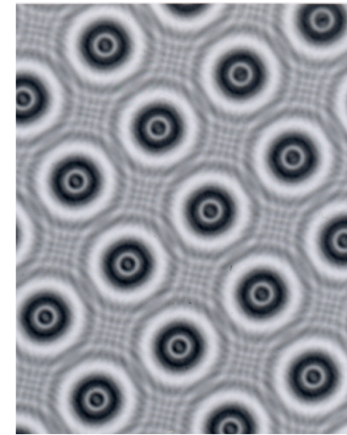
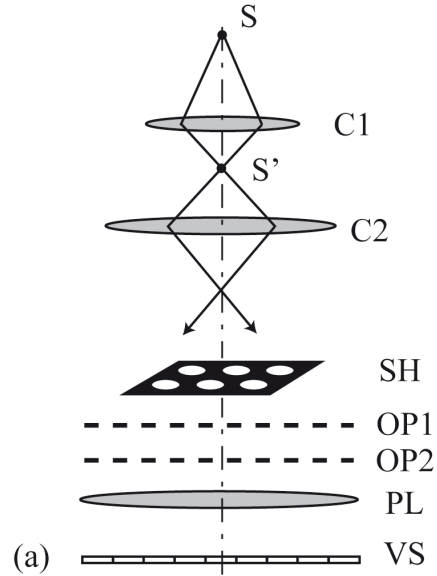


(b)

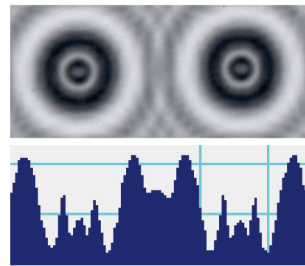
FIGURA DI DIFFRAZIONE CON ELETTRONI – FENDITURA CIRCOLARE



DIFFRAZIONE DI FRESNEL CON ELETTRONI - MOLTE FENDITURE

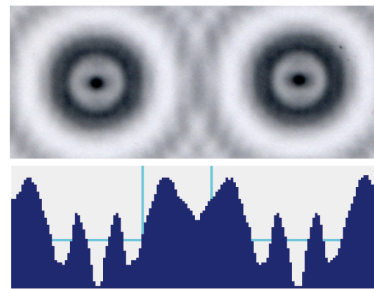


**NUMERO DISPARI
ZONE FRESNEL**



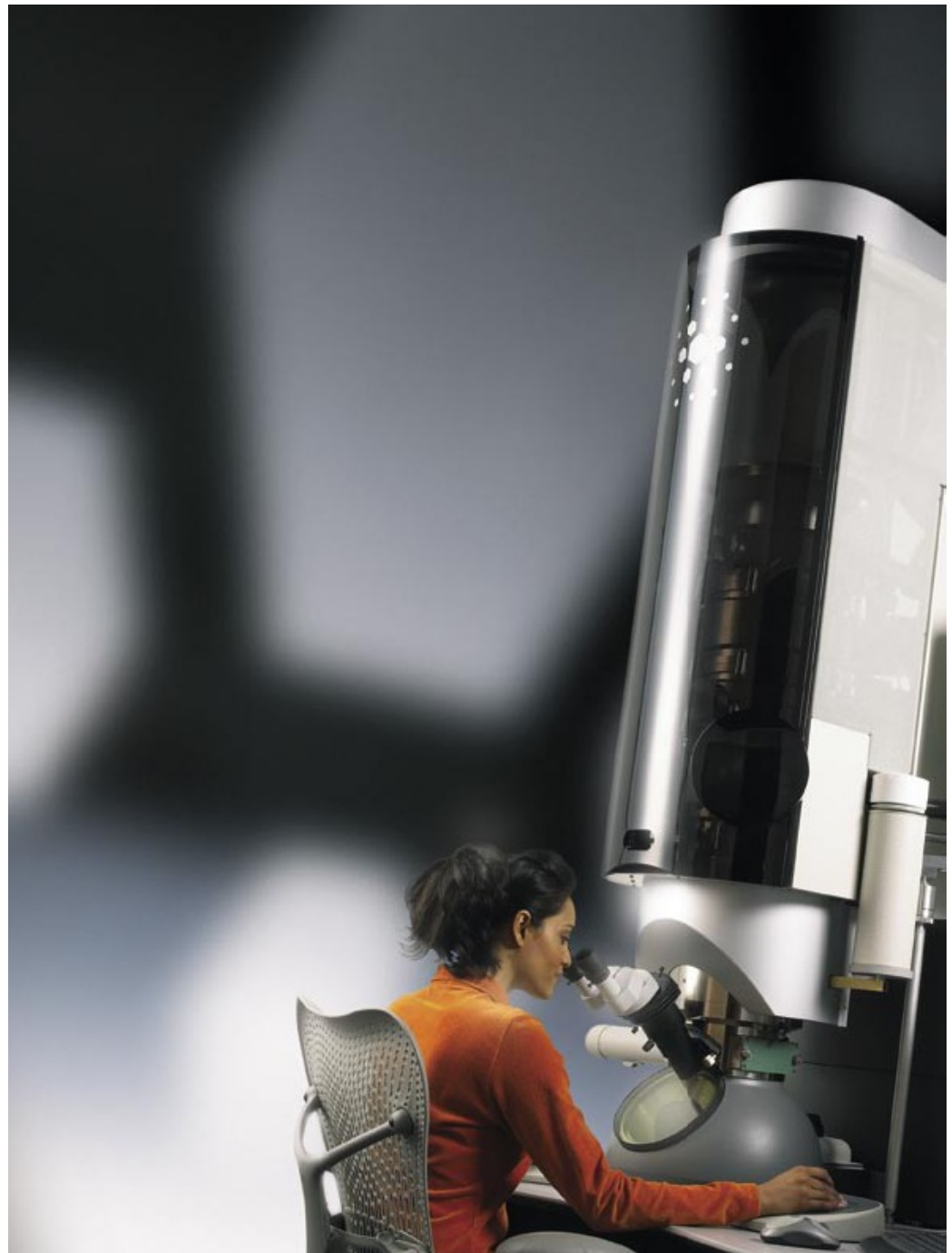
(c)

**NUMERO PARI
ZONE FRESNEL**



(d)

**MICROSCOPIO
ELETTRONICO IN
TRASMISSIONE - FEI**



RETICOLO ATOMICO IN UN BORDO DI GRANO DELL' ORO

